

Solid solutions with AlB_2 -type structure in R -Ag-Al-Ge systems ($R = Ce, Pr, Nd, Sm$)

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An investigation of the quaternary systems R -Ag-Al-Ge ($R = Ce, Pr, Nd, Sm$) at 873 K led to the discovery of three complete solid solutions based on ternary germanides, $CeAg_{0.8}Ge_{1.2}$ - $CeAl_{1.6-1.5}Ge_{0.4-0.5}$, $PrAg_{0.8}Ge_{1.2}$ - $PrAl_{1.55-1.48}Ge_{0.45-0.52}$, and $NdAg_{0.7}Ge_{1.3}$ - $NdAl_{1.63-1.50}Ge_{0.37-0.50}$, and a quaternary compound, $SmAg_{0.55-0.36}Al_{0.43-0.80}Ge_{1.02-0.84}$, with AlB_2 -type structure (Pearson symbol $hP3$, space group $P6/mmm$). The crystal structure of the solid solution in the system Pr-Ag-Al-Ge was refined for the composition $PrAg_{0.38}Al_{0.80}Ge_{0.82}$ from X-ray powder ($a = 0.43368(5)$, $c = 0.41929(7)$ nm) and single-crystal ($a = 0.4318(1)$, $c = 0.4191(1)$ nm) diffraction data. Within the homogeneity range the contact distances between small-size atoms decrease with increasing Al and decreasing Ag and Ge content. The valence electron concentration per atom of the statistical mixture Ag+Al+Ge increases from 4.30 to 4.76 within the same range.

Rare-earth / Silver / Aluminum / Germanium / Solid solution / X-ray diffraction / Crystal structure

Introduction

The formation of ternary compounds with hexagonal AlB_2 -type structure ($hP3$, $P6/mmm$) has been reported for the RAg_2-RGe_2 and RAl_2-RGe_2 cross-sections of the R -Ag-Ge and R -Al-Ge systems (where R is a light rare-earth metal) [1-7]. The compounds in the systems R -Ag-Ge, except for $R = Sm$, are characterized by point compositions: $LaAg_{0.8}Ge_{1.2}$ (773 K), $CeAg_{0.8}Ge_{1.2}$ (773 K), $PrAg_{0.8}Ge_{1.2}$ (873 K), $NdAg_{0.7}Ge_{1.3}$ (1073 K), $EuAgGe$ (673 K), $EuAg_{0.8}Ge_{1.2}$ (973 K), and $GdAg_{0.6}Ge_{1.4}$ (873 K) [1-3]. On the contrary, the alumogermanides of La, Ce, Pr, Nd, and Eu have significant homogeneity ranges: $LaAl_{1.8-1.5}Ge_{0.2-0.5}$ (773 K), $CeAl_{1.6-1.5}Ge_{0.4-0.5}$ (773 K), $PrAl_{1.55-1.48}Ge_{0.45-0.52}$ (673 and 873 K), $NdAl_{1.63-1.50}Ge_{0.37-0.50}$ (1273 K), and $EuAl_{1.08-1.00}Ge_{0.92-1.00}$ (873 K) [4-7]. The isotypic compound in the Sm-Al-Ge system has the point composition $SmAl_{1.5}Ge_{0.5}$ (1273 K) [4]. Literature data show the existence of numerous AlB_2 -type compounds in related ternary systems. For instance, in the R -{Fe,Co,Zn}-Ge systems the following compounds have been reported: $RFe_{0.67}Ge_{1.33}$ for $R = La, Nd, Sm$ (1873 K), $RCo_{0.5}Ge_{1.5}$ for $R = Ce, Pr, Nd$ (873 K), $RZn_{1.5}Ge_{0.5}$ for $R = La, Ce, Pr, Nd, Sm$ (1073 K) [1]. A modulated structure derived from the AlB_2 type was described in [8] for the quaternary compound $Pr(Ni_{0.20}Al_{0.30}Ge_{0.50})_{1.8}$. The existence of the complete solid solution $PrAg_{0.8}Ge_{1.2}$ -

$PrAl_{1.55-1.48}Ge_{0.45-0.52}$ (873 K) and the quaternary compound $SmAg_{0.55-0.36}Al_{0.43-0.80}Ge_{1.02-0.84}$ (873 K) with AlB_2 -type structure was briefly reported in [9-11]. The aim of the present work was in addition to look for regularities in the formation of the AlB_2 -type compounds in the quaternary systems {Ce,Pr,Nd,Sm}-Ag-Al-Ge.

Experimental

Two three-component and 23 four-component alloys containing 33.3 at.% rare-earth element were synthesized by arc-melting the elements (Ce, Pr, Nd, Sm ≥ 99.83 wt.%, Al ≥ 99.985 wt.%, Ag and Ge ≥ 99.999 wt.%) under argon atmosphere. The samples were annealed at 873 K in evacuated quartz ampoules for 1 month and subsequently quenched in cold water. The weight losses during the preparation of the samples were less than 1 % of the total mass, which was 1 g for each alloy.

Phase analysis was carried out using X-ray powder diffraction data collected on a diffractometer DRON-2.0M (Fe $K\alpha$ radiation) in the angular range $20 \leq 2\theta \leq 100^\circ$ with the step 0.05° . The profile and structural parameters were refined by the Rietveld method using the program DBWS-9807 [12]. X-ray single-crystal diffraction data were collected in the ω - 2θ scan mode on a four-circle CAD-4T diffractometer (graphite

Table 1 Phases detected in alloys of the Ce–Ag–Al–Ge system at 873 K, 33.3 at.% Ce.

No.	Sample composition, at. %	Phase	Structure type	Unit-cell parameters		
				<i>a</i> , nm	<i>c</i> , nm	<i>V</i> , nm ³
1	Ce _{33.3} Ag _{26.7} Ge _{40.0}	CeAg _{0.8} Ge _{1.2}	AlB ₂	0.43900(5)	0.41305(6)	0.06894(2)
		CeAgGe	LiGaGe	0.45350(9)	0.7725(3)	0.13759(6)
2	Ce _{33.3} Ag _{23.3} Al _{6.7} Ge _{36.7}	CeAg _{0.70} Al _{0.20} Ge _{1.10}	AlB ₂	0.43901(6)	0.41407(8)	0.06911(2)
		CeAgGe	LiGaGe	0.4506(1)	0.7834(8)	0.1377(2)
3	Ce _{33.3} Ag _{20.0} Al _{13.3} Ge _{33.4}	CeAg _{0.60} Al _{0.40} Ge _{1.00}	AlB ₂	0.43832(7)	0.41603(9)	0.06922(2)
4	Ce _{33.3} Ag _{16.7} Al _{20.0} Ge _{30.0}	CeAg _{0.50} Al _{0.60} Ge _{0.90}	AlB ₂	0.43619(6)	0.42133(8)	0.06942(2)
5	Ce _{33.3} Ag _{13.3} Al _{26.7} Ge _{26.7}	CeAg _{0.40} Al _{0.80} Ge _{0.80}	AlB ₂	0.43487(6)	0.42474(7)	0.06956(2)
6	Ce _{33.3} Ag _{8.0} Al _{36.7} Ge _{22.0}	CeAg _{0.24} Al _{1.10} Ge _{0.66}	AlB ₂	0.43543(7)	0.42603(9)	0.06995(2)
7	Ce _{33.3} Ag _{2.7} Al _{46.7} Ge _{17.3}	CeAg _{0.08} Al _{1.40} Ge _{0.52}	AlB ₂	0.43480(5)	0.42953(7)	0.07032(2)

Table 2 Phases detected in alloys of the Pr–Ag–Al–Ge system at 873 K, 33.3 at.% Pr.

No.	Sample composition, at. %	Phase	Structure type	Unit-cell parameters		
				<i>a</i> , nm	<i>c</i> , nm	<i>V</i> , nm ³
1	Pr _{33.3} Ag _{23.3} Al _{6.7} Ge _{36.7}	PrAg _{0.70} Al _{0.20} Ge _{1.10}	AlB ₂	0.43722(6)	0.40981(7)	0.06785(2)
2	Pr _{33.3} Ag _{16.7} Al _{16.7} Ge _{33.3}	PrAg _{0.50} Al _{0.50} Ge _{1.00}	AlB ₂	0.43415(6)	0.41652(8)	0.06799(2)
3	Pr _{33.3} Ag _{13.3} Al _{20.0} Ge _{33.4}	PrAg _{0.40} Al _{0.60} Ge _{1.00}	AlB ₂	0.43215(8)	0.41858(9)	0.06769(3)
4	Pr _{33.3} Ag _{12.7} Al _{26.7} Ge _{27.3}	PrAg _{0.38} Al _{0.80} Ge _{0.82}	AlB ₂	0.43368(5)	0.41929(7)	0.06830(2)
5	Pr _{33.3} Ag _{8.4} Al _{33.3} Ge _{25.0}	PrAg _{0.25} Al _{1.00} Ge _{0.75}	AlB ₂	0.43253(6)	0.42244(7)	0.06844(2)
6	Pr _{33.3} Ag _{3.3} Al _{43.4} Ge _{20.0}	PrAg _{0.10} Al _{1.30} Ge _{0.60}	AlB ₂	0.43288(9)	0.42389(9)	0.06880(2)

monochromator, Mo K α radiation). An analytical absorption correction was applied. A full-matrix least-squares refinement of the structural parameters was performed on F^2 using the program SHELXL-97 [13]. An energy-dispersive X-ray analysis was performed on a REM-106I electron scanning microscope.

Results and discussion

The phases identified in the samples synthesized at 873 K in the R–Ag–Al–Ge systems ($R = \text{Ce, Pr, Nd, Sm}$) and their refined unit-cell parameters as obtained from X-ray powder diffraction data are listed in Tables 1–4. The existence of the ternary compounds CeAg_{0.8}Ge_{1.2} (structure type AlB₂, $P6/mmm$), CeAgGe (LiGaGe, $P6_3mc$), Nd₃Ag₄Ge₄ (Gd₃Cu₄Ge₄, $Immm$), NdAg_{0.7}Ge_{1.3} (AlB₂, $P6/mmm$), and NdAg_{1.4}Ge_{0.6} (Fe₂P, $P-62m$) was confirmed based on the phase analysis of the ternary samples Ce_{33.3}Ag_{26.7}Ge_{40.0} and Nd_{33.3}Ag_{23.4}Ge_{43.3}. Differently from [3], we observed the existence of the ternary compound NdAg_{0.7}Ge_{1.3} at a lower temperature (873 K). The quaternary alloys were single-phase samples containing phases with AlB₂-type structure, except Ce_{33.3}Ag_{23.3}Al_{6.7}Ge_{36.7} and some alloys from the Sm–Ag–Al–Ge system, which contained as additional phases CeAgGe or Sm₃Ag₄Ge₄ (Gd₃Cu₄Ge₄, $Immm$) and SmAg_{1.4}Ge_{0.6} (Fe₂P, $P-62m$). Consequently, the following solid solutions with AlB₂-type structure were found at 33.3 at.% R and 873 K in the systems {Ce,Pr,Nd,Sm}–Ag–Al–Ge: CeAg_{0.8}Ge_{1.2}–CeAl_{1.6–1.5}Ge_{0.4–0.5}, PrAg_{0.8}Ge_{1.2}–PrAl_{1.55–1.48}Ge_{0.45–0.52}, NdAg_{0.7}Ge_{1.3}–NdAl_{1.63–1.50}Ge_{0.37–0.50} and SmAg_{0.55–0.36}Al_{0.43–0.80}Ge_{1.02–0.84}.

The variation of the unit-cell parameters within the homogeneity ranges of the AlB₂-type compounds in the quaternary systems {Ce,Pr,Nd,Sm}–Ag–Al–Ge is shown in Fig. 1. The a -parameter decreases with increasing Al content (0–54.3 at.%) and decreasing Ag and Ge content (26.7–0 and 43.3–12.3 at.%, respectively), whereas the c -parameter increases. In the AlB₂-type structure each small-size atom (in our case a statistical mixture of Ag, Al, and Ge atoms) has three "homoatomic" bonds, so that infinite graphite-like planar nets perpendicular to the 6-fold axes are formed. The large-size atoms (rare-earth metal atoms here) are situated between the nets and form trigonal prisms. All the space in the structure is filled up by R_6 trigonal prisms, the centers of which are occupied by atoms of the statistical mixture $M = \text{Ag+Al+Ge}$. The replacement of Ag and Ge atoms (covalent radii $r = 0.134$ and 0.122 nm, respectively) by Al atoms ($r = 0.118$ nm) directly influences the a -parameter, which reflects the contact distances between small-size atoms in the structure ($\delta_{M-M} = a/\sqrt{3}$). The trigonal prisms are slightly compressed along the prism axis ($c/a < 1$), however, the c/a ratio increases with increasing Al content. An important criterion for the formation of solid solutions, in addition to the atom-size factor, is the number of valence electrons. For the AlB₂-type phases studied here the valence electron concentration per atom of the statistical mixture $M = \text{Ag+Al+Ge}$ (VEC_A [14]) is in the range 4.30–4.76. The replacement of Ag atoms with one valence electron and Ge atoms with four valence electrons in the ratio Ag:Ge = 1:1, by Al atoms with three valence electrons leads to an increase of VEC_A . It should be noticed that for other extended solid solutions in the systems

- CeAg_{0.8}Ge_{1.2}–CeAl_{1.6–1.5}Ge_{0.4–0.5}
- PrAg_{0.8}Ge_{1.2}–PrAl_{1.55–1.48}Ge_{0.45–0.52}
- NdAg_{0.7}Ge_{1.3}–NdAl_{1.63–1.50}Ge_{0.37–0.52}
- ⊕ SmAg_{0.55–0.36}Al_{0.43–0.80}Ge_{1.02–0.84}

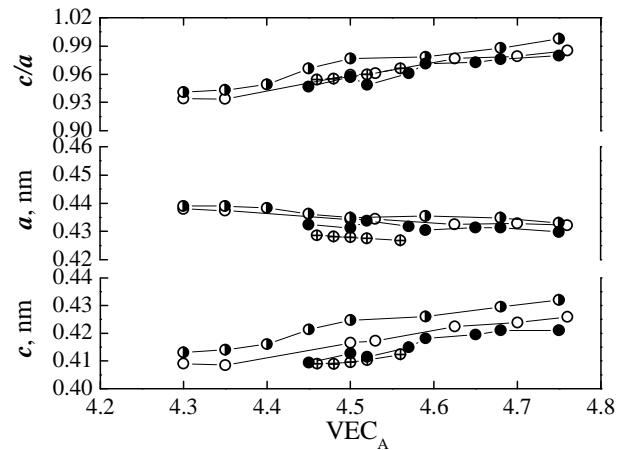


Fig. 1 Unit-cell parameters within the homogeneity ranges of the AlB₂-type compounds in the quaternary systems {Ce,Pr,Nd,Sm}–Ag–Al–Ge as a function of the valence electron concentration VEC_A.

Table 3 Phases detected in alloys of the Nd–Ag–Al–Ge system at 873 K, 33.3 at.% Nd.

No.	Sample composition, at. %	Phase	Structure type	Unit-cell parameters			
				a, nm	b, nm	c, nm	V, nm ³
1	Nd _{33.3} Ag _{23.4} Ge _{43.3}	Nd ₃ Ag ₄ Ge ₄	Gd ₃ Cu ₄ Ge ₄	0.4413(1)	0.7111(2)	1.4667(4)	0.4603(2)
		NdAg _{0.7} Ge _{1.3}	AlB ₂	0.4324(1)	–	0.4094(1)	0.06627(3)
		NdAg _{1.4} Ge _{0.6}	ZrNiAl	0.7268(2)	–	0.4305(2)	0.1969(1)
2	Nd _{33.3} Ag _{20.0} Al _{16.7} Ge _{40.0}	NdAg _{0.60} Al _{0.20} Ge _{1.20}	AlB ₂	0.43121(7)	–	0.41274(9)	0.06646(2)
3	Nd _{33.3} Ag _{17.3} Al _{13.3} Ge _{36.0}	NdAg _{0.52} Al _{0.40} Ge _{1.08}	AlB ₂	0.43379(6)	–	0.41144(8)	0.06705(2)
4	Nd _{33.3} Ag _{14.0} Al _{20.0} Ge _{32.7}	NdAg _{0.42} Al _{0.60} Ge _{0.98}	AlB ₂	0.43177(5)	–	0.41493(6)	0.06700(1)
5	Nd _{33.3} Ag _{11.3} Al _{26.7} Ge _{28.7}	NdAg _{0.34} Al _{0.80} Ge _{0.86}	AlB ₂	0.43048(5)	–	0.41811(6)	0.06710(1)
6	Nd _{33.3} Ag _{6.7} Al _{36.7} Ge _{23.3}	NdAg _{0.20} Al _{1.10} Ge _{0.70}	AlB ₂	0.43138(4)	–	0.41951(5)	0.06761(1)
7	Nd _{33.3} Ag _{2.7} Al _{46.7} Ge _{17.3}	NdAg _{0.08} Al _{1.40} Ge _{0.52}	AlB ₂	0.43138(5)	–	0.42100(6)	0.06785(1)

Table 4 Phases detected in alloys of the Sm–Ag–Al–Ge system at 873 K, 33.3 at.% Sm.

No.	Sample composition, at. %	Phase	Structure type	Unit-cell parameters			
				a, nm	b, nm	c, nm	V, nm ³
1	Sm _{33.3} Ag _{20.0} Al _{12.0} Ge _{34.7}	SmAg _{0.55} Al _{0.43} Ge _{1.02}	AlB ₂	0.42860(6)	–	0.4090(7)	0.06507(2)
		Sm ₃ Ag ₄ Ge ₄	Gd ₃ Cu ₄ Ge ₄	0.4427(1)	0.6978(2)	1.4572(4)	0.4501(2)
		SmAg _{1.4} Ge _{0.6}	ZrNiAl	0.7145(2)	–	0.4322(1)	0.1911(1)
2	Sm _{33.3} Ag _{16.7} Al _{16.7} Ge _{33.3}	SmAg _{0.50} Al _{0.50} Ge _{1.00}	AlB ₂	0.42793(4)	–	0.40949(6)	0.06494(1)
		Sm ₃ Ag ₄ Ge ₄	Gd ₃ Cu ₄ Ge ₄	0.4389(1)	0.7048(2)	1.4489(3)	0.4482(2)
		SmAg _{1.4} Ge _{0.6}	ZrNiAl	0.7185(1)	–	0.4274(1)	0.19111(7)
3	Sm _{33.3} Ag _{16.0} Al _{20.0} Ge _{30.7}	SmAg _{0.48} Al _{0.60} Ge _{0.92}	AlB ₂	0.42812(6)	–	0.40893(9)	0.06491(2)
		SmAg _{1.4} Ge _{0.6}	ZrNiAl	0.7161(1)	–	0.4304(1)	0.19114(6)
		Sm ₃ Ag ₄ Ge ₄	Gd ₃ Cu ₄ Ge ₄	0.4394(1)	0.7042(2)	1.4493(4)	0.4484(2)
4	Sm _{33.3} Ag _{14.0} Al _{23.3} Ge _{29.4}	SmAg _{0.42} Al _{0.70} Ge _{0.88}	AlB ₂	0.42756(3)	–	0.41030(4)	0.06496(1)
		SmAg _{1.4} Ge _{0.6}	ZrNiAl	0.71165(9)	–	0.43434(9)	0.19051(5)
		Sm ₃ Ag ₄ Ge ₄	Gd ₃ Cu ₄ Ge ₄	0.4442(1)	0.6954(2)	1.4599(6)	0.4510(3)
5	Sm _{33.3} Ag _{12.0} Al _{26.7} Ge _{28.0}	SmAg _{0.36} Al _{0.80} Ge _{0.84}	AlB ₂	0.42676(5)	–	0.41233(6)	0.06503(1)
		Sm ₃ Ag ₄ Ge ₄	Gd ₃ Cu ₄ Ge ₄	0.4447(2)	0.6949(3)	1.4629(6)	0.4521(3)
		SmAg _{1.4} Ge _{0.6}	ZrNiAl	0.7115(1)	–	0.4351(1)	0.19074(8)

{Pr,Sm}–Ag–Al–Ge at 33.3 at.% R and 873 K, VEC_A = 3.65–4.17 (Fe₂P-type structures) and 4.77–5.00 (α-ThSi₂-type structures).

The crystal structure of the PrAg_{0.8}Ge_{1.2}–PrAl_{1.55–1.48}Ge_{0.45–0.52} solid solution was investigated by X-ray powder and single-crystal diffraction. The

results of the structure refinement for the polycrystalline sample of composition Pr_{33.3}Ag_{12.7}Al_{26.7}Ge_{27.3} are presented in Table 5. A pseudo-Voigt function with four parameters was used for the profile refinement. Atomic coordinates and isotropic displacement parameters are listed in Table 6

Table 5 Details of the structure refinement for the polycrystalline sample $Pr_{33.3}Ag_{12.7}Al_{26.7}Ge_{27.3}$ (diffractometer DRON-2.0M, Fe $K\alpha$ radiation).

Phase		$PrAg_{0.38}Al_{0.80}Ge_{0.82}$
Space group		$P6/mmm$
Unit-cell parameters	a , nm	0.43368(5)
	c , nm	0.41929(7)
	V , nm ³	0.06830(2)
Formula units per cell Z		1
Density D_X , g cm ⁻³		6.394
Texture parameter G		1.062(8) [001]
FWHM parameters U, V, W		0.23(2), 0, 0.029(4)
Mixing parameter η		0.63(4)
Asymmetry parameter C_M		-0.19(4)
Number of refined parameters		11
Reliability factors R_B, R_p, R_{wp}		0.0908, 0.0468, 0.0580
Goodness of fit S		0.61

Table 6 Atomic coordinates and isotropic displacement parameters for $PrAg_{0.38}Al_{0.80}Ge_{0.82}$ (powder data, structure type AlB_2 , Pearson symbol $hP3$, space group $P6/mmm$, $a = 0.43368(5)$, $c = 0.41929(7)$ nm).

Site	Wyckoff position	x	y	z	B_{iso} , 10^{-2} nm ²
Pr	$1a$	0	0	0	0.5(2)
M	$2d$	1/3	2/3	1/2	1.3(2)

$$M = 0.19Ag + 0.40Al + 0.41Ge$$

Table 7 Interatomic distances for $PrAg_{0.38}Al_{0.80}Ge_{0.82}$ (powder data).

Atoms		δ , nm
Pr	-12 M	0.32657(3)
	-2 Pr	0.41932(6)
	-6 Pr	0.43367(5)
M	-3 M	0.25038(3)
	-6 Pr	0.32657(3)

$$M = 0.19Ag + 0.40Al + 0.41Ge$$

and selected interatomic distances are given in **Table 7**. In the AlB_2 -type structure the small-size atoms occupy one Wyckoff position ($2d$) and in the refinement the Ag:Al:Ge ratio was fixed according to the nominal composition of the alloy ($PrAg_{0.38}Al_{0.80}Ge_{0.82}$). An energy-dispersive X-ray analysis showed good agreement between the nominal composition of the sample and the composition of the quaternary phase ($Pr_{33(2)}Ag_{14(2)}Al_{29(4)}Ge_{24(3)}$). A backscattered electron image of the sample $Pr_{33.3}Ag_{12.7}Al_{26.7}Ge_{27.3}$ is presented in **Fig. 2** and the observed, calculated and difference X-ray powder diffraction patterns of the same alloy are shown in **Fig. 3**. Experimental details of a structure refinement based on diffraction data collected for a single crystal extracted from the same alloy are listed in **Table 8**. No superstructure or satellite reflections were observed. Atomic coordinates and equivalent isotropic displacement parameters assuming an AlB_2 -type structure without vacancies are presented in **Table 9**,

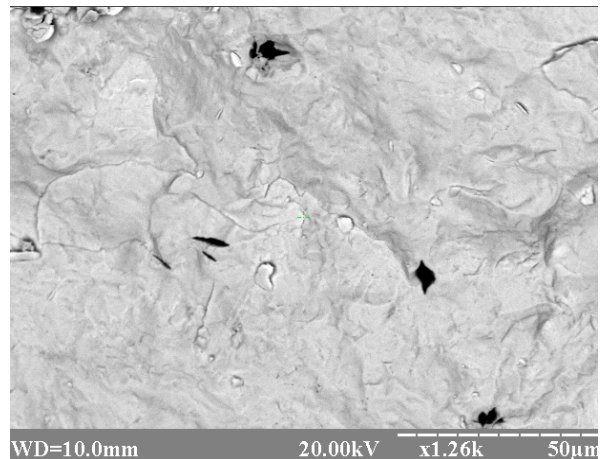
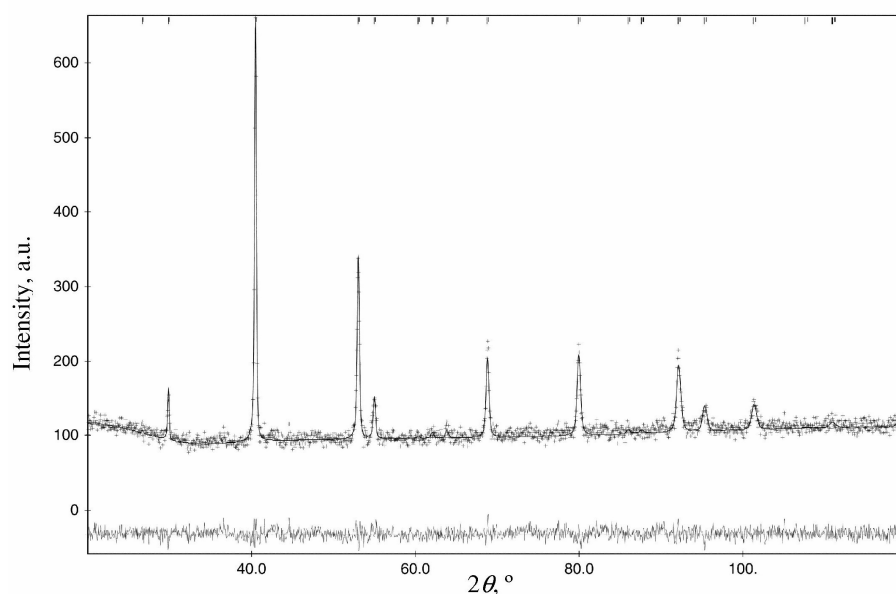


Fig. 2 Backscattered electron image of the sample $Pr_{33.3}Ag_{12.7}Al_{26.7}Ge_{27.3}$.

Table 8 Details of the data collection and structure refinement for PrAg_{0.38}Al_{0.80}Ge_{0.82} (single-crystal data, diffractometer CAD-4T, Mo K α radiation).

Space group		<i>P6/mmm</i>
Unit-cell parameters	<i>a</i> , nm	0.4318(1)
	<i>c</i> , nm	0.4191(1)
	<i>V</i> , nm ³	0.06767(3)
Formula units per cell <i>Z</i>		1
Density <i>D_x</i> , g cm ⁻³		6.454
Absorption coefficient μ , mm ⁻¹		24.96
Crystal size, mm		0.08 × 0.07 × 0.05
Data collection method		ω -2 θ scan
Number of measured reflections		1241
Number of independent reflections		146
Number of reflections with $I > 2\sigma(I)$		141
Factor <i>R</i> _{int}		0.0890
Range <i>h, k, l</i>		-8 ≤ <i>h</i> ≤ 7, -2 ≤ <i>k</i> ≤ 8, -8 ≤ <i>l</i> ≤ 8
Refinement on		<i>F</i> ²
Reliability factors	<i>R</i> (for $I > 2\sigma(I)$)	0.0346 (0.0337)
	<i>wR</i>	0.0641 (0.0639)
Goodness of fit <i>S</i>		1.176
Number of refined parameters		7
Weighting scheme		$w = 1/[(\sigma F_o)^2 + (0.0133P)^2]$ ($P = (F_o^2 + 2F_c^2)/3$)
Extinction coefficient		0.08(2)

**Fig. 3** Observed (dots), calculated (line) and difference (bottom) X-ray powder diffraction patterns for the Pr_{33.3}Ag_{12.7}Al_{26.7}Ge_{27.3} sample (Fe K α radiation).

anisotropic displacement parameters and selected interatomic distances are listed in [Tables 10](#) and [11](#), respectively. In this case the Ag:Al:Ge ratio was not fixed but the occupancy of the site was refined as a mixture between the heaviest (Ag) and the lightest (Al) elements. The refined composition 0.50(1)Ag + 0.50(1)Al corresponds to an average number of electrons of 30.0(3) for the atoms in the 2*d* site (to be compared with 27 electrons used for the refinement on

powder diffraction data).

As can be seen from [Tables 11-15](#), the distances between *M* atoms correspond to the average covalent radius of the small-size atoms ($r_{av} = (xr_{Ag} + yr_{Al} + zr_{Ge})/(x+y+z)$, where *x*, *y* and *z* are the relative quantities of Ag, Al and Ge in the statistical mixture). These distances are similar to those in the pure metals ($\delta_{Ag-Ag} = 0.289$, $\delta_{Al-Al} = 0.286$, $\delta_{Ge-Ge} = 0.245$ nm).

Table 9 Atomic coordinates and equivalent displacement parameters for $\text{PrAg}_{0.38}\text{Al}_{0.80}\text{Ge}_{0.82}$ (single-crystal data, structure type AlB_2 , Pearson symbol $hP3$, space group $P6/mmm$, $a = 0.4318(1)$, $c = 0.4191(1)$ nm).

Site	Wyckoff position	x	y	z	U_{eq} , 10^{-2} nm^2
Pr	$1a$	0	0	0	0.0072(2)
M	$2d$	1/3	2/3	1/2	0.0185(5)

 $M = 0.50(1)\text{Ag} + 0.50(1)\text{Al}$ used for the refinement**Table 10** Anisotropic displacement parameters (10^{-2} nm^2) for $\text{PrAg}_{0.38}\text{Al}_{0.80}\text{Ge}_{0.82}$ (single-crystal data).

Site	U_{11}	U_{22}	U_{33}	U_{12}	U_{13}	U_{23}
Pr	0.0065(2)	0.0065(2)	0.0101(3)	0.0032(1)	0	0
M	0.0091(5)	0.0091(5)	0.0374(8)	0.0045(2)	0	0

 $M = 0.50(1)\text{Ag} + 0.50(1)\text{Al}$ **Table 11** Interatomic distances for $\text{PrAg}_{0.38}\text{Al}_{0.80}\text{Ge}_{0.82}$ (single-crystal data).

Atoms		δ , nm
Pr	-12 M	0.32566(6)
	-2 Pr	0.4191(1)
	-6 Pr	0.4318(1)
M	-3 M	0.24930(7)
	-6 Pr	0.32566(6)

 $M = 0.50(1)\text{Ag} + 0.50(1)\text{Al}$ **Table 12** Interaxial ratio c/a , valence electron concentration VEC_A , contact distances between small atoms δ_{M-M} , and sum of the average covalent radii $2r_M$ for the solid solution $\text{CeAg}_{0.8}\text{Ge}_{1.2}\text{-CeAl}_{1.6-1.5}\text{Ge}_{0.4-0.5}$.

Composition	c/a	VEC_A	δ_{M-M} , nm	$2r_M$, nm
$\text{CeAg}_{0.80}\text{Ge}_{1.20}$	0.9409	4.30	0.2535	0.2536
$\text{CeAg}_{0.70}\text{Al}_{0.20}\text{Ge}_{1.10}$	0.9432	4.35	0.2535	0.2516
$\text{CeAg}_{0.60}\text{Al}_{0.40}\text{Ge}_{1.00}$	0.9492	4.40	0.2531	0.2496
$\text{CeAg}_{0.50}\text{Al}_{0.60}\text{Ge}_{0.90}$	0.9659	4.45	0.2518	0.2476
$\text{CeAg}_{0.40}\text{Al}_{0.80}\text{Ge}_{0.80}$	0.9767	4.50	0.2511	0.2456
$\text{CeAg}_{0.24}\text{Al}_{1.10}\text{Ge}_{0.66}$	0.9784	4.59	0.2514	0.2425
$\text{CeAg}_{0.08}\text{Al}_{1.40}\text{Ge}_{0.52}$	0.9879	4.68	0.2510	0.2394
$\text{CeAl}_{1.50}\text{Ge}_{0.50}$ [5]	0.9977	4.75	0.2450	0.2380

Table 13 Interaxial ratio c/a , valence electron concentration VEC_A , contact distances between small atoms δ_{M-M} , and sum of the average covalent radii $2r_M$ for the solid solution $\text{PrAg}_{0.8}\text{Ge}_{1.2}\text{-PrAl}_{1.55-1.48}\text{Ge}_{0.45-0.52}$.

Composition	c/a	VEC_A	δ_{M-M} , nm	$2r_M$, nm
$\text{PrAg}_{0.80}\text{Ge}_{1.20}$ [2]	0.9340	4.30	0.2528	0.2536
$\text{PrAg}_{0.70}\text{Al}_{0.20}\text{Ge}_{1.10}$	0.9337	4.35	0.2524	0.2516
$\text{PrAg}_{0.50}\text{Al}_{0.50}\text{Ge}_{1.00}$	0.9593	4.50	0.2507	0.2480
$\text{PrAg}_{0.40}\text{Al}_{0.60}\text{Ge}_{1.00}$	0.9686	4.60	0.2495	0.2464
$\text{PrAg}_{0.38}\text{Al}_{0.80}\text{Ge}_{0.82}$	0.9611	4.53	0.2504	0.2454
$\text{PrAg}_{0.25}\text{Al}_{1.00}\text{Ge}_{0.75}$	0.9767	4.63	0.2497	0.2430
$\text{PrAg}_{0.10}\text{Al}_{1.30}\text{Ge}_{0.60}$	0.9792	4.70	0.2499	0.2400
$\text{PrAl}_{1.48}\text{Ge}_{0.52}$ [6]	0.9852	4.76	0.2495	0.2381

Table 14 Interaxial ratio c/a , valence electron concentration VEC_A , contact distances between small atoms δ_{M-M} , and sum of the average covalent radii $2r_M$ for the solid solution $\text{NdAg}_{0.7}\text{Ge}_{1.3}\text{-NdAl}_{1.63\text{-}1.50}\text{Ge}_{0.37\text{-}0.50}$.

Composition	c/a	VEC_A	δ_{M-M} , nm	$2r_M$, nm
$\text{NdAg}_{0.70}\text{Ge}_{1.30}$	0.9468	4.45	0.2496	0.2524
$\text{NdAg}_{0.60}\text{Al}_{0.20}\text{Ge}_{1.20}$	0.9572	4.50	0.2490	0.2504
$\text{NdAg}_{0.52}\text{Al}_{0.40}\text{Ge}_{1.08}$	0.9485	4.52	0.2504	0.2486
$\text{NdAg}_{0.42}\text{Al}_{0.60}\text{Ge}_{0.98}$	0.9610	4.57	0.2493	0.2466
$\text{NdAg}_{0.34}\text{Al}_{0.80}\text{Ge}_{0.86}$	0.9713	4.59	0.2485	0.2449
$\text{NdAg}_{0.20}\text{Al}_{1.10}\text{Ge}_{0.70}$	0.9725	4.65	0.2491	0.2420
$\text{NdAg}_{0.08}\text{Al}_{1.40}\text{Ge}_{0.52}$	0.9759	4.68	0.2491	0.2394
$\text{NdAl}_{1.50}\text{Ge}_{0.50}$ [7]	0.9795	4.75	0.2481	0.2380

Table 15 Interaxial ratio c/a , valence electron concentration VEC_A , contact distances between small atoms δ_{M-M} , and sum of the average covalent radii $2r_M$ for the compound $\text{SmAg}_{0.55\text{-}0.36}\text{Al}_{0.43\text{-}0.80}\text{Ge}_{1.02\text{-}0.84}$.

Composition	c/a	VEC_A	δ_{M-M} , nm	$2r_M$, nm
$\text{SmAg}_{0.55}\text{Al}_{0.43}\text{Ge}_{1.02}$	0.9543	4.46	0.2475	0.2489
$\text{SmAg}_{0.50}\text{Al}_{0.50}\text{Ge}_{1.00}$	0.9569	4.50	0.2471	0.2480
$\text{SmAg}_{0.48}\text{Al}_{0.60}\text{Ge}_{0.92}$	0.9552	4.48	0.2472	0.2474
$\text{SmAg}_{0.42}\text{Al}_{0.70}\text{Ge}_{0.88}$	0.9596	4.52	0.2468	0.2462
$\text{SmAg}_{0.36}\text{Al}_{0.80}\text{Ge}_{0.84}$	0.9662	4.56	0.2464	0.2451

Conclusions

AlB_2 -type phases were observed in the systems $\{\text{Ce,Pr,Nd,Sm}\}\text{-Ag-Al-Ge}$ at 873 K. In the systems with Ce, Pr, and Nd they form complete solid solutions between ternary compounds $\text{CeAg}_{0.8}\text{Ge}_{1.2}\text{-CeAl}_{1.6\text{-}1.5}\text{Ge}_{0.4\text{-}0.5}$, $\text{PrAg}_{0.8}\text{Ge}_{1.2}\text{-PrAl}_{1.55\text{-}1.48}\text{Ge}_{0.45\text{-}0.52}$, and $\text{NdAg}_{0.7}\text{Ge}_{1.3}\text{-NdAl}_{1.63\text{-}1.50}\text{Ge}_{0.37\text{-}0.50}$, whereas in the system with Sm a quaternary compound with a significant homogeneity range, $\text{SmAg}_{0.55\text{-}0.36}\text{Al}_{0.43\text{-}0.80}\text{Ge}_{1.02\text{-}0.84}$, is formed. The valence electron concentration per atom of the statistical mixture Ag+Al+Ge (VEC_A) is in the range 4.30-4.76. Increase of the Al and decrease of the Ag and Ge contents lead to shortening of the contact distances between small-size atoms in the infinite graphite-like planar nets perpendicular to the 6-fold axes.

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